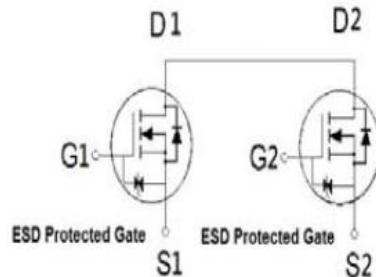
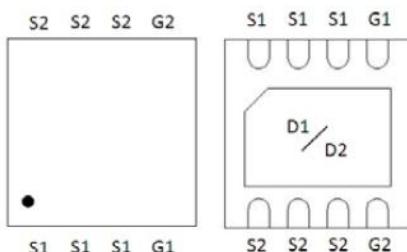


PE5C6JZ

Dual N-Channel Enhancement Mode MOSFET

PRODUCT SUMMARY

$V_{(BR)DSS}$	$R_{DS(ON)}$	I_D
24V	5.5mΩ @ $V_{GS} = 4.5V$	54A



PDFN 3X3S

ABSOLUTE MAXIMUM RATINGS ($T_A = 25^\circ C$ Unless Otherwise Noted)

PARAMETERS/TEST CONDITIONS	SYMBOL	LIMITS	UNITS
Drain-Source Voltage	V_{DS}	24	V
Gate-Source Voltage	V_{GS}	± 12	V
Continuous Drain Current ²	I_D	54	A
		34	
		16	
		13	
Pulsed Drain Current ¹	I_{DM}	90	
Avalanche Current	I_{AS}	28	
Avalanche Energy	E_{AS}	39	mJ
Power Dissipation	P_D	27	W
		11	
		2.5	
		1.6	
Operating Junction & Storage Temperature Range	T_J, T_{stg}	-55 to 150	°C

THERMAL RESISTANCE RATINGS

THERMAL RESISTANCE	SYMBOL	TYPICAL	MAXIMUM	UNITS
Junction-to-Ambient ³	$R_{\theta JA}$	50	4.5	°C / W
Junction-to-Case	$R_{\theta JC}$			

¹Pulse width limited by maximum junction temperature.

²Package limitation current is 13A.

³The value of $R_{\theta JA}$ is measured with the device mounted on 1in² FR-4 board with 2oz. Copper, in a still air environment with $T_A = 25^\circ C$.

PE5C6JZ

Dual N-Channel Enhancement Mode MOSFET

ELECTRICAL CHARACTERISTICS ($T_J = 25^\circ\text{C}$, Unless Otherwise Noted)

PARAMETER	SYMBOL	TEST CONDITIONS	LIMITS			UNITS
			MIN	TYP	MAX	
STATIC						
Drain-Source Breakdown Voltage	$V_{(\text{BR})\text{DSS}}$	$V_{\text{GS}} = 0\text{V}, I_D = 250\mu\text{A}$	24			V
Gate Threshold Voltage	$V_{\text{GS}(\text{th})}$	$V_{\text{DS}} = V_{\text{GS}}, I_D = 250\mu\text{A}$	0.6	0.9	1.2	
Gate-Body Leakage	I_{GSS}	$V_{\text{DS}} = 0\text{V}, V_{\text{GS}} = \pm 10\text{V}$			± 10	μA
Zero Gate Voltage Drain Current	I_{DSS}	$V_{\text{DS}} = 20\text{V}, V_{\text{GS}} = 0\text{V}$			1	μA
		$V_{\text{DS}} = 20\text{V}, V_{\text{GS}} = 0\text{V}, T_J = 125^\circ\text{C}$			10	
Drain-Source On-State Resistance ¹	$R_{\text{DS}(\text{ON})}$	$V_{\text{GS}} = 4.5\text{V}, I_D = 3\text{A}$	3.6	4.6	5.5	$\text{m}\Omega$
		$V_{\text{GS}} = 3.8\text{V}, I_D = 3\text{A}$	3.9	4.9	6	
		$V_{\text{GS}} = 3.1\text{V}, I_D = 3\text{A}$	4.3	5.3	6.9	
		$V_{\text{GS}} = 2.5\text{V}, I_D = 3\text{A}$	5	6	8.5	
Forward Transconductance ¹	g_{fs}	$V_{\text{DS}} = 5\text{V}, I_D = 3\text{A}$		24		S
DYNAMIC						
Input Capacitance	C_{iss}	$V_{\text{GS}} = 0\text{V}, V_{\text{DS}} = 12\text{V}, f = 1\text{MHz}$		1774		pF
Output Capacitance	C_{oss}			327		
Reverse Transfer Capacitance	C_{rss}			267		
Gate Resistance	R_g	$V_{\text{GS}} = 0\text{V}, V_{\text{DS}} = 0\text{V}, f = 1\text{MHz}$		1.8		Ω
Total Gate Charge ²	$Q_g(V_{\text{GS}}=4.5\text{V})$	$V_{\text{DS}} = 12\text{V}, I_D = 3\text{A}$		24		nC
	$Q_g(V_{\text{GS}}=3.9\text{V})$			21.4		
Gate-Source Charge ²	Q_{gs}			2.2		
Gate-Drain Charge ²	Q_{gd}			9		
Turn-On Delay Time ²	$t_{\text{d}(\text{on})}$	$V_{\text{DD}} = 12\text{V}, I_D \geq 3\text{A}, V_{\text{GEN}} = 4.5\text{V}, R_G = 6\Omega$		20		nS
Rise Time ²	t_r			38		
Turn-Off Delay Time ²	$t_{\text{d}(\text{off})}$			70		
Fall Time ²	t_f			18		
SOURCE-DRAIN DIODE RATINGS AND CHARACTERISTICS ($T_J = 25^\circ\text{C}$)						
Continuous Current ³	I_S	$I_F = 3\text{A}, V_{\text{GS}} = 0\text{V}$			22	A
Forward Voltage ¹	V_{SD}				1.2	V
Reverse Recovery Time	t_{rr}			28		nS
Reverse Recovery Charge	Q_{rr}			13		nC

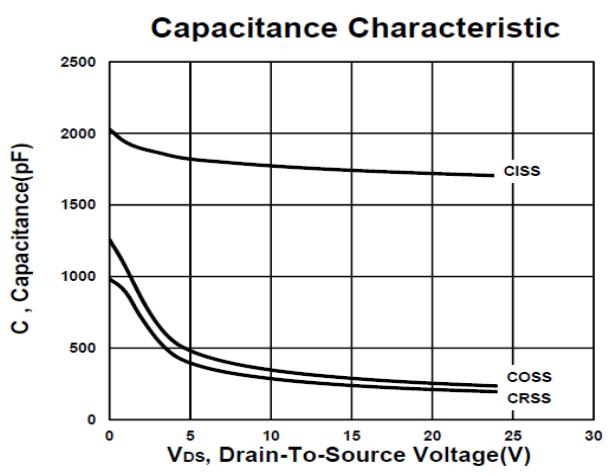
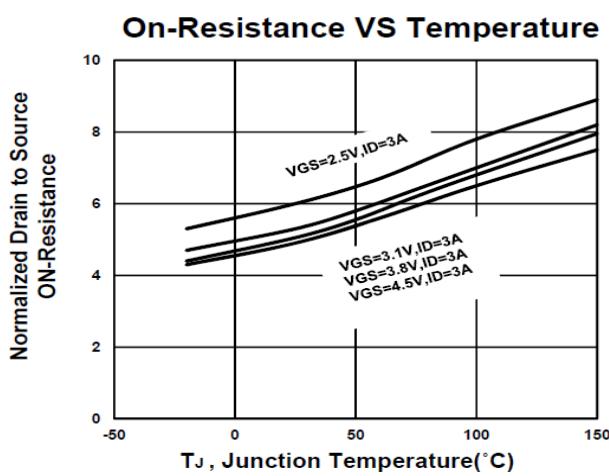
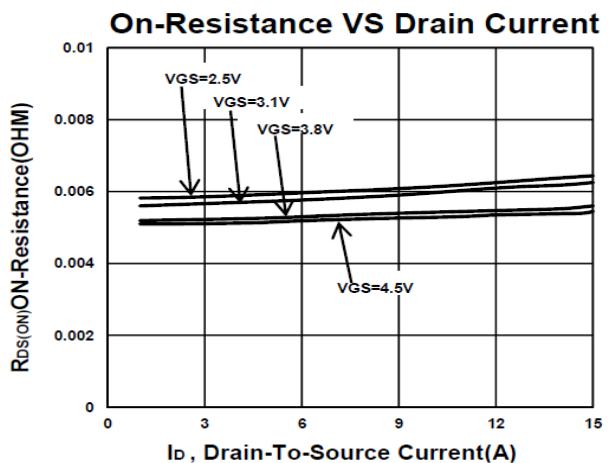
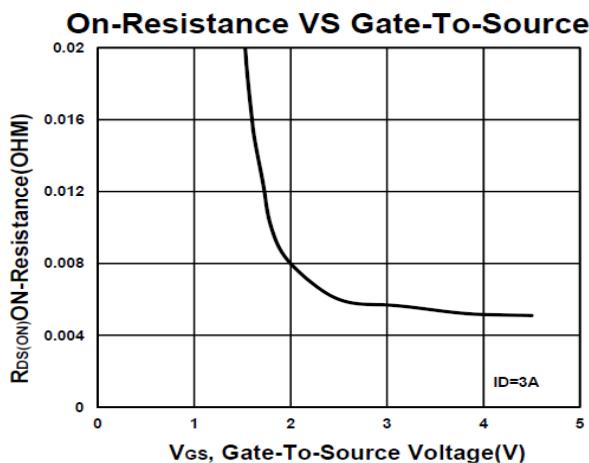
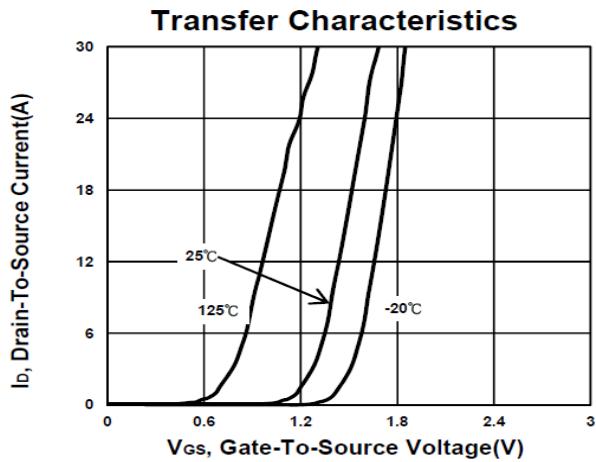
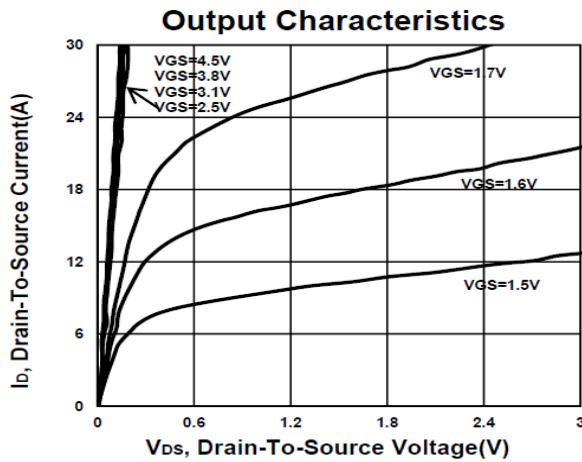
¹Pulse test : Pulse Width $\leq 300\text{ }\mu\text{sec}$, Duty Cycle $\leq 2\%$.

²Independent of operating temperature.

³Package limitation current is 13A.

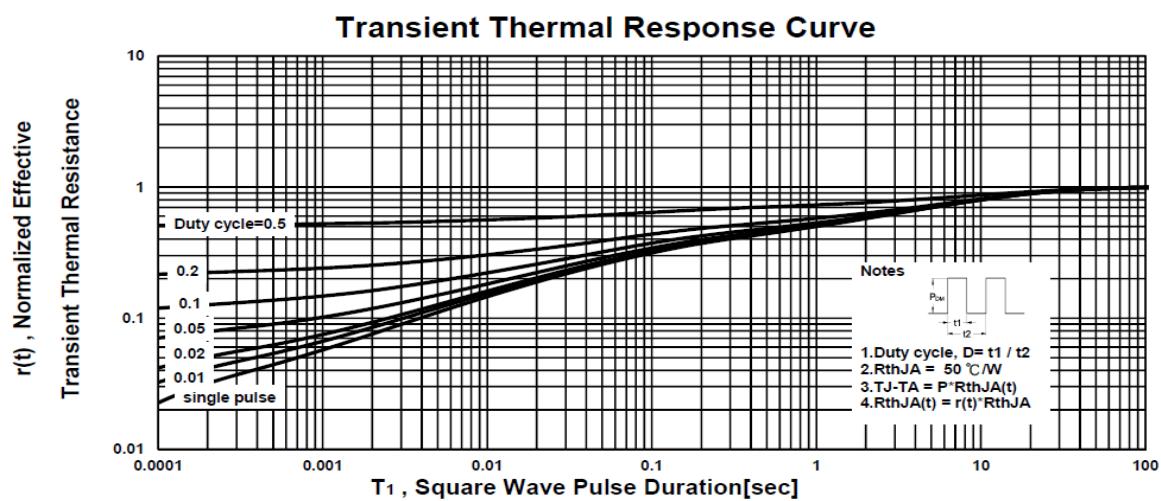
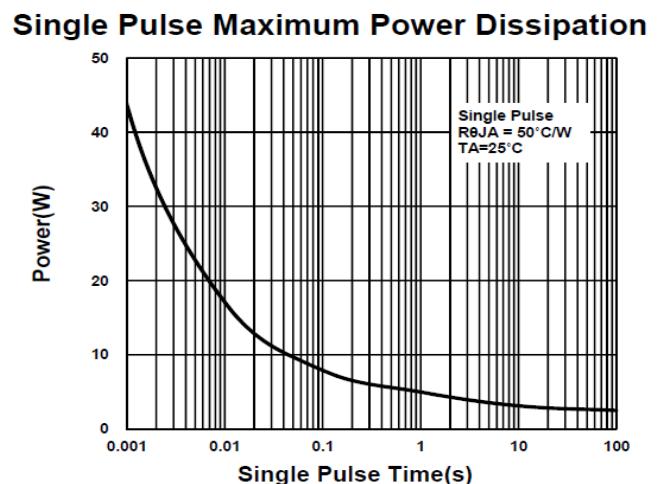
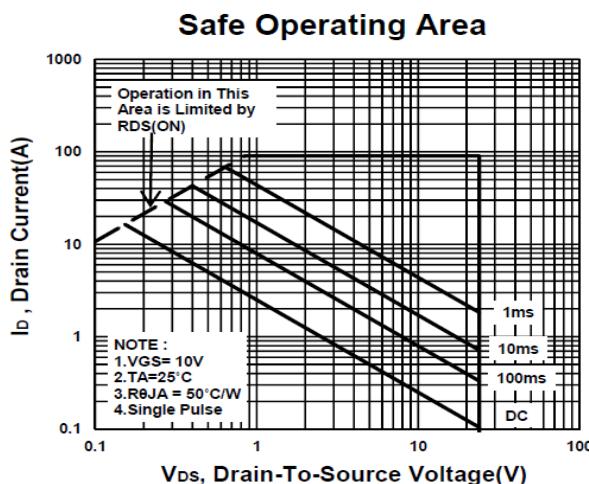
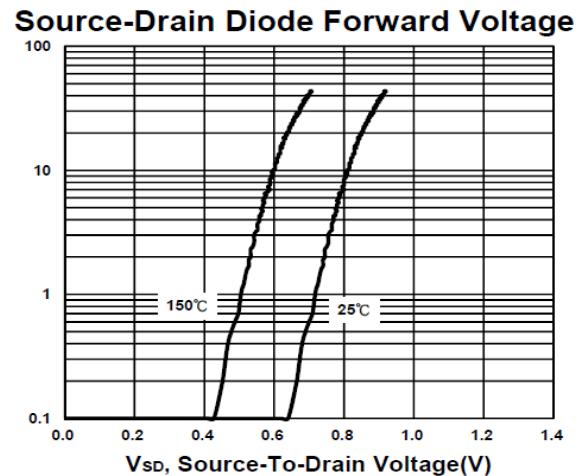
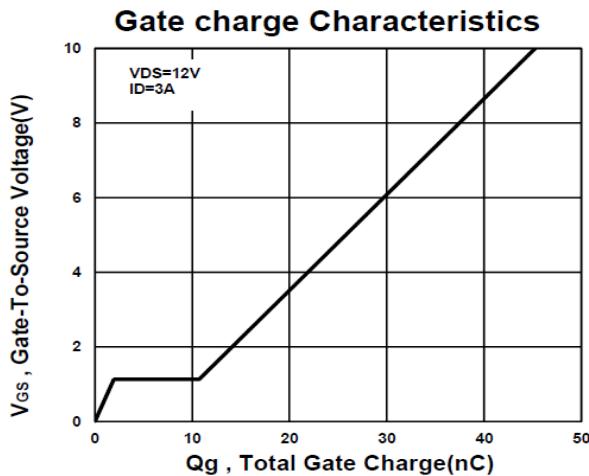
PE5C6JZ

Dual N-Channel Enhancement Mode MOSFET



PE5C6JZ

Dual N-Channel Enhancement Mode MOSFET



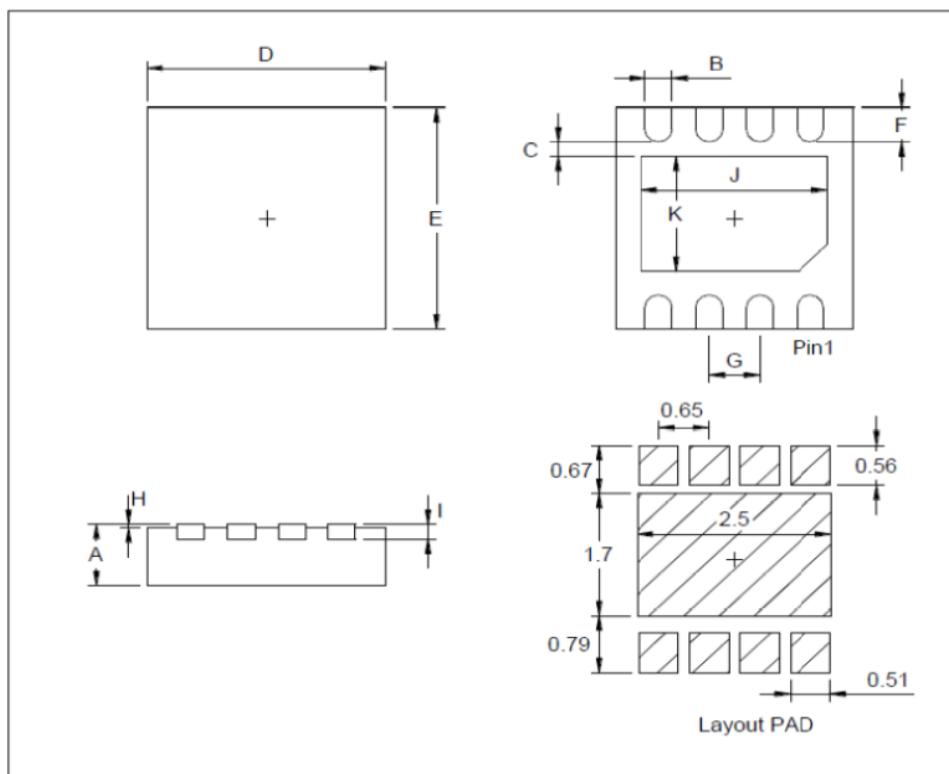
PE5C6JZ

Dual N-Channel Enhancement Mode MOSFET

Package Dimension

PDFN 3x3S MECHANICAL DATA

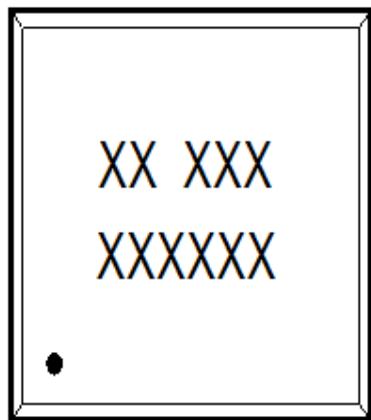
Dimension	mm			Dimension	mm		
	Min.	Typ.	Max.		Min.	Typ.	Max.
A	0.70		0.90	I	0.195		0.211
B	0.25		0.35	J	2.20		2.40
C	0.25		0.45	K	1.40		1.60
D	2.90		3.10				
E	2.90		3.10				
F	0.324		0.476				
G	0.55	0.65	0.75				
H	0		0.05				



PE5C6JZ

Dual N-Channel Enhancement Mode MOSFET

A. Marking Information(此产品代码为: K2)

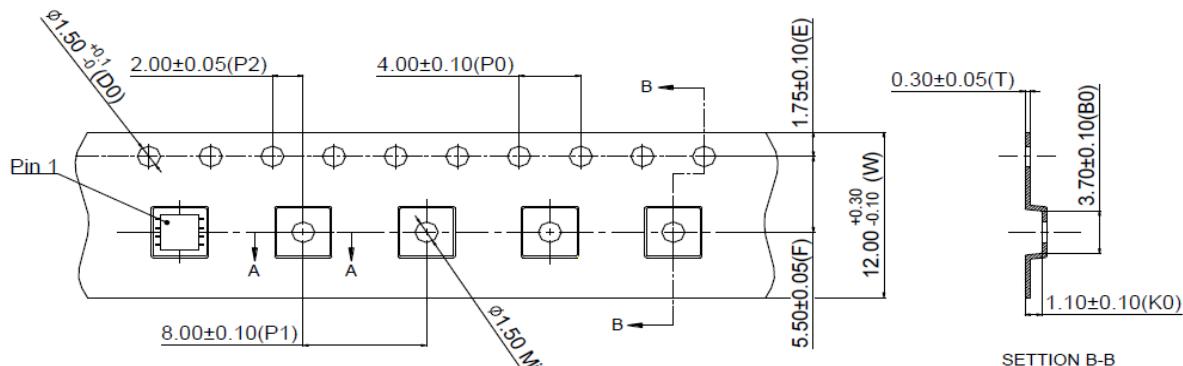


XX(前两码):产品代码

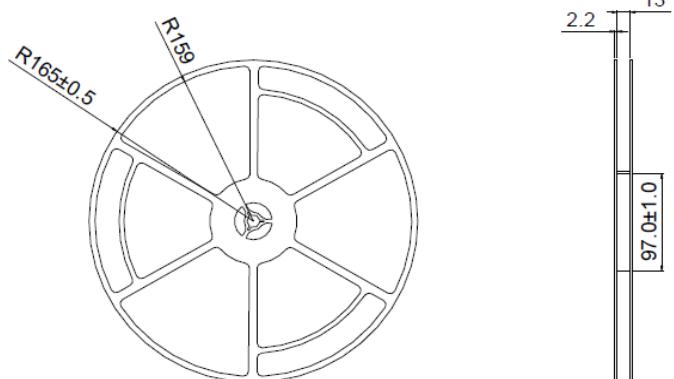
XXX

XXXXXX(后九码):LOT.NO

B. Tape&Reel Information:5000pcs/Reel



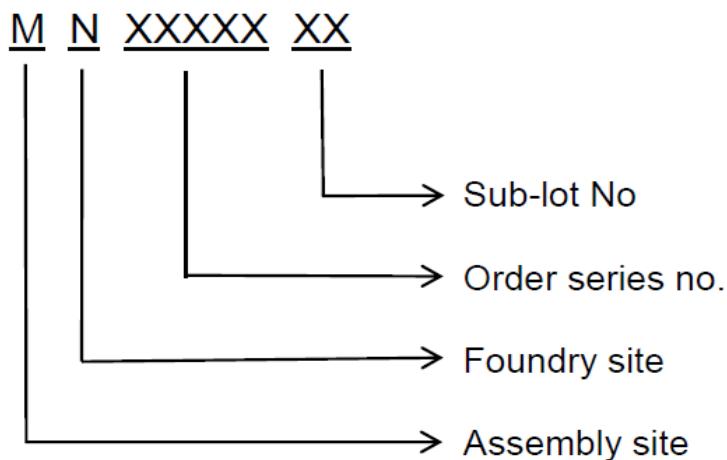
SECTION B-B



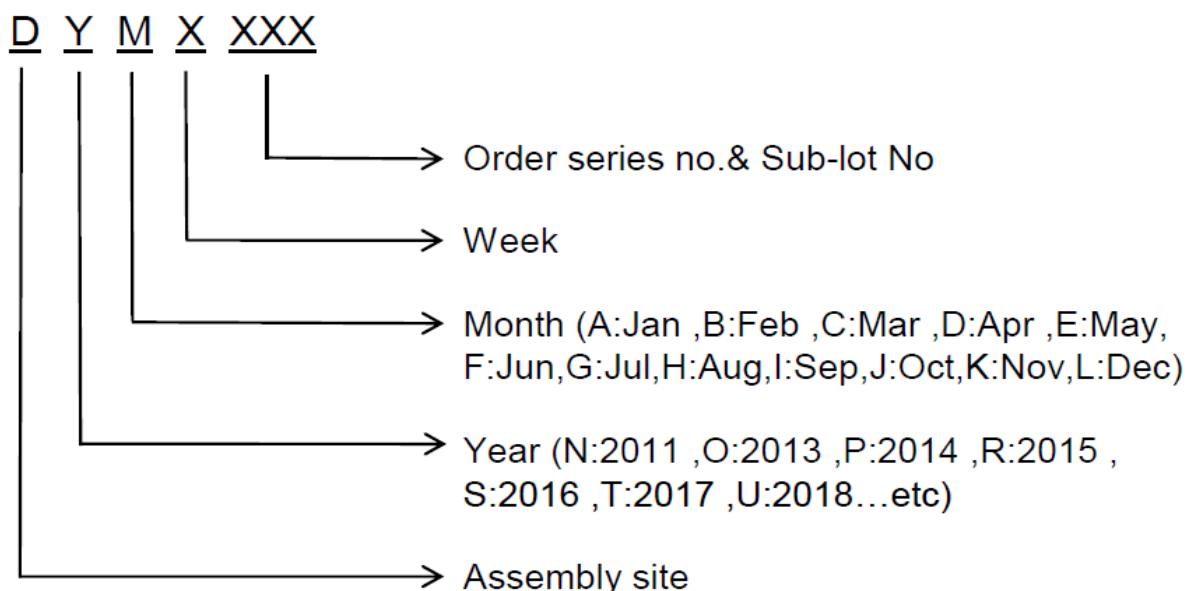
PE5C6JZ **Dual N-Channel Enhancement Mode MOSFET**

C. Lot No.&Date Code rule

1.Lot No.



2.Date Code



PE5C6JZ

Dual N-Channel Enhancement Mode MOSFET

D.Label rule

标签内容(Label content)



1	Label Size	30 * 90 mm			
2	Font style	Times New Roman or Arial (或可区分英文“0”和数字“0”，“G”和“Q”的字型即可)			
3	U-NIKC	Height: 4 mm			
4	Package	Height: 2 mm			
5	Date	Height: 2 mm Shipping date: YYYY/MM/DD, ex. 2008/09/12			
6	Device	Height: 3 mm (Max: 16 Digit)			
7	Lot	Height: 3 mm (Max: 9 Digit) Sub lot			
8	D/C	Height: 3 mm (Max: 7 Digit)			
9	QTY	Height: 3 mm (Max: 6 Digit) Thousand mark is no needed			
10	RoHS label	 long axis: 12 mm minor axis: 6 mm bottom color: White Font color: Black Font style: Arial			
11	Halogen Free label	 Diameter: 10 mm bottom color: Green Font color: Black Font style: Arial			
12	Scan information	Device / Lot / D/C / QTY , Insert “ / “ between every parts. for example: P3055LDG/G12345601/GGG2301/2000 DPI (Dots per inch): Over 300 dpi Code : Code 128 Height: 6 mm at least			